



## Description

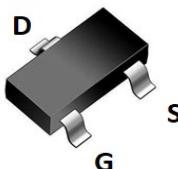
### JMT N-channel Enhancement Mode Power MOSFET

#### Features

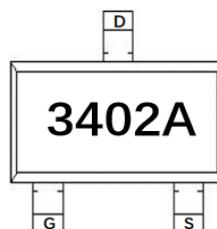
- 30V, 4A
- $R_{DS(ON)} < 44m\Omega$  @  $V_{GS} = 10V$
- $R_{DS(ON)} < 48m\Omega$  @  $V_{GS} = 4.5V$
- $R_{DS(ON)} < 60m\Omega$  @  $V_{GS} = 2.5V$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge

#### Applications

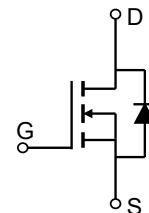
- Load Switch
- PWM Application
- Power Management



SOT-23 Top View



Marking and Pin Assignment



Schematic

#### Package Marking and Ordering Information

Device Marking	Device	Outline	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
3402A	JMTL3402A	TAPING	SOT-23	7"	3000	120000

#### Absolute Maximum Ratings (@ $T_A = 25^\circ C$ unless otherwise specified)

Symbol	Parameter		Value		Units	
$V_{DS}$	Drain-to-Source Voltage		30		V	
$V_{GS}$	Gate-to-Source Voltage		$\pm 12$		V	
$I_D$	Continuous Drain Current	$T_A = 25^\circ C$	4	3	A	
		$T_A = 100^\circ C$	3			
$I_{DM}$	Pulsed Drain Current <sup>(1)</sup>		16	A		
$P_D$	Power Dissipation	$T_A = 25^\circ C$	1.2	W		
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>(2)</sup>		103	°C/W		
$T_J, T_{STG}$	Junction & Storage Temperature Range		-55 to 150	°C		

**Electrical Characteristics** ( $T_J = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 30\text{V}, V_{GS} = 0\text{V}$	-	-	1.0	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.5	1.0	1.4	V
$R_{\text{DS(ON)}}$	Static Drain-Source ON-Resistance <sup>(3)</sup>	$V_{GS} = 10\text{V}, I_D = 4\text{A}$	-	34	44	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 3\text{A}$	-	37	48	$\text{m}\Omega$
		$V_{GS} = 2.5\text{V}, I_D = 2\text{A}$	-	46	60	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 15\text{V}, f = 1\text{MHz}$	-	414	-	pF
$C_{\text{oss}}$	Output Capacitance		-	36	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	29	-	pF
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ to } 4.5\text{V}$ $V_{DS} = 15\text{V}, I_D = 2\text{A}$	-	4.5	-	nC
$Q_{gs}$	Gate Source Charge		-	1	-	nC
$Q_{gd}$	Gate Drain("Miller") Charge		-	1	-	nC
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{GS} = 4.5\text{V}, V_{DD} = 15\text{V}$ $I_D = 2\text{A}, R_{\text{GEN}} = 3\Omega$	-	4	-	ns
$t_r$	Turn-On Rise Time		-	13	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	41	-	ns
$t_f$	Turn-Off Fall Time		-	17	-	ns
<b>Drain-Source Diode Characteristics and Max Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	4	-	A
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	16	-	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 4\text{A}$	-	-	1.2	V
$trr$	Body Diode Reverse Recovery Time	$I_F = 2\text{A}, di/dt = 100\text{A/us}$	-	6	-	ns
$Qrr$	Body Diode Reverse Recovery Charge		-	1	-	nC

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .

## Typical Performance Characteristics

Figure 1: Output Characteristics

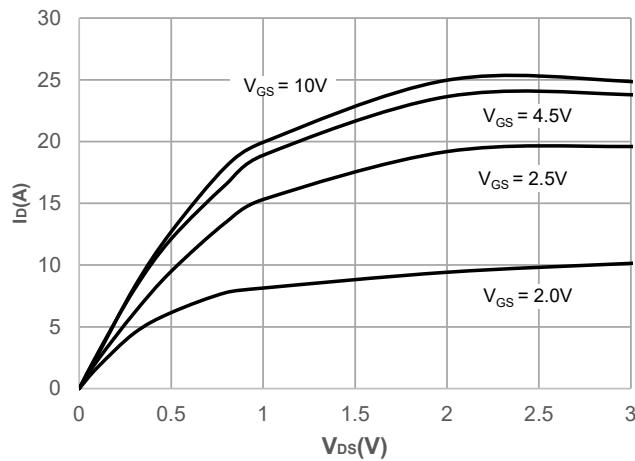


Figure 2: Typical Transfer Characteristics

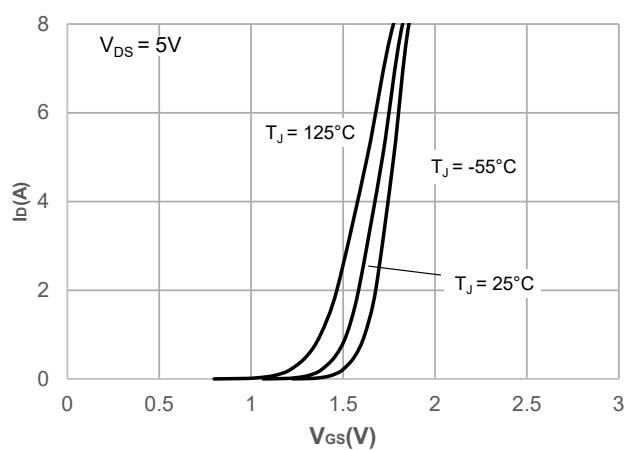


Figure 3: On-resistance vs. Drain Current

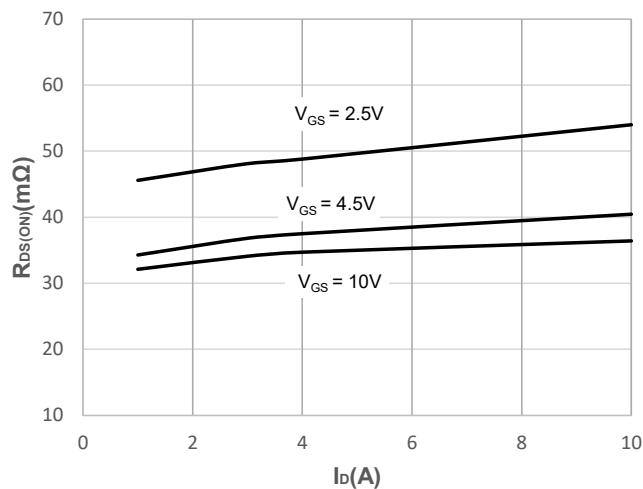


Figure 4: Body Diode Characteristics

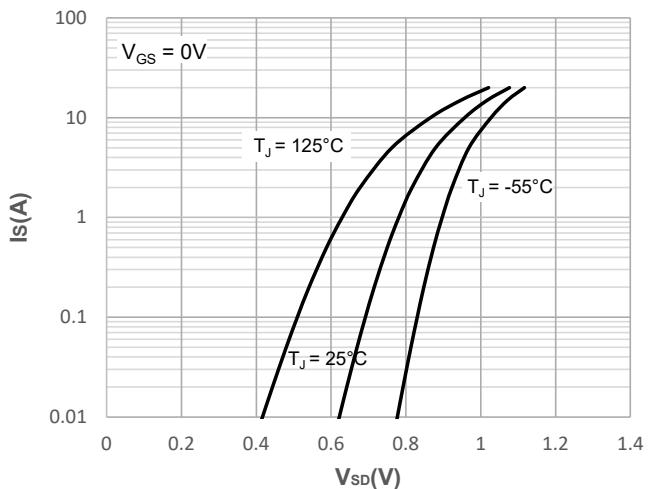


Figure 5: Gate Charge Characteristics

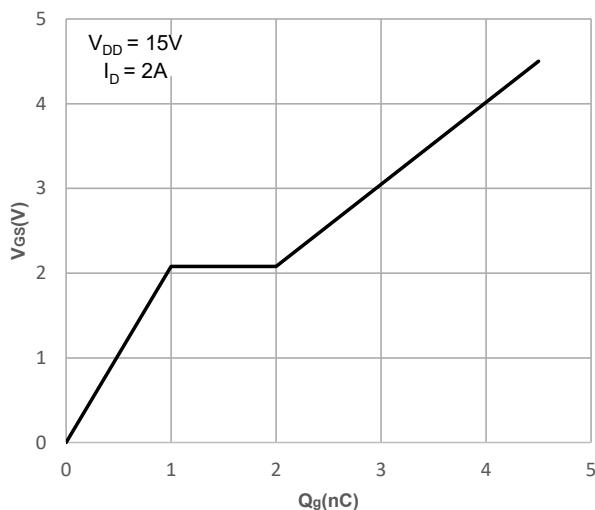
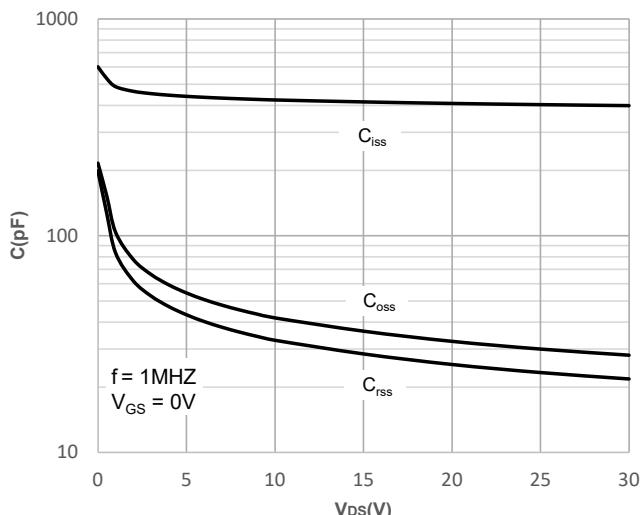
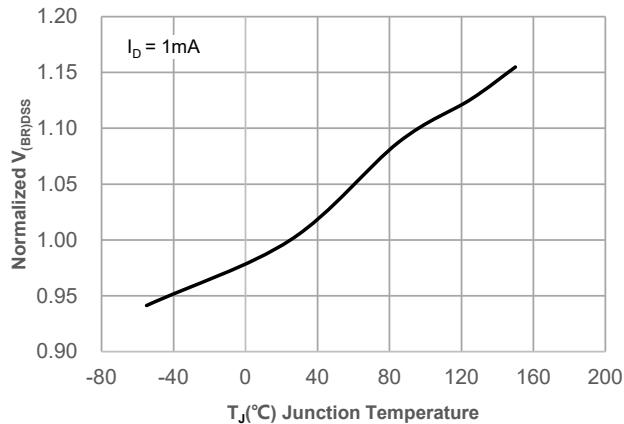


Figure 6: Capacitance Characteristics

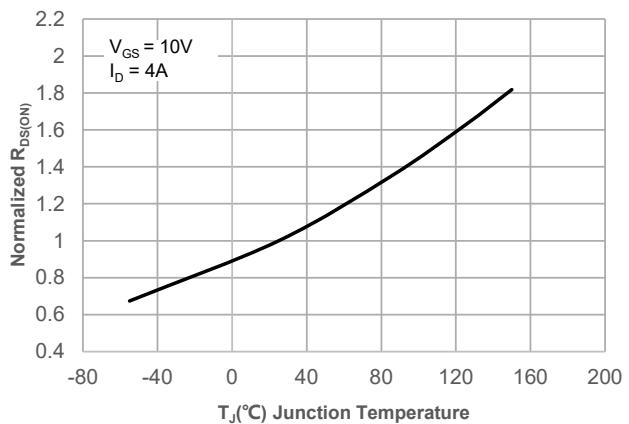


## Typical Performance Characteristics

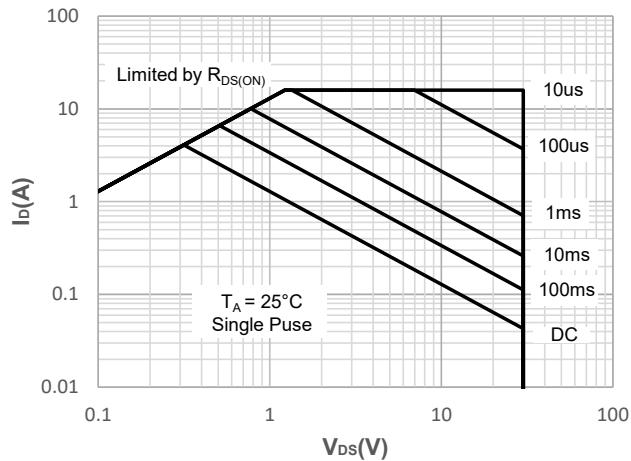
**Figure 7: Normalized Breakdown voltage vs. Junction Temperature**



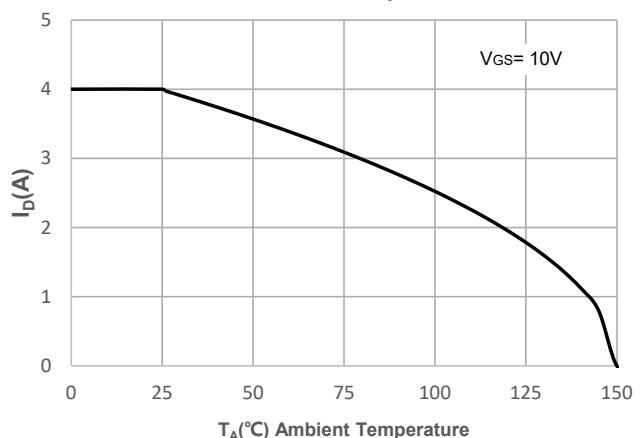
**Figure 8: Normalized on Resistance vs. Junction Temperature**



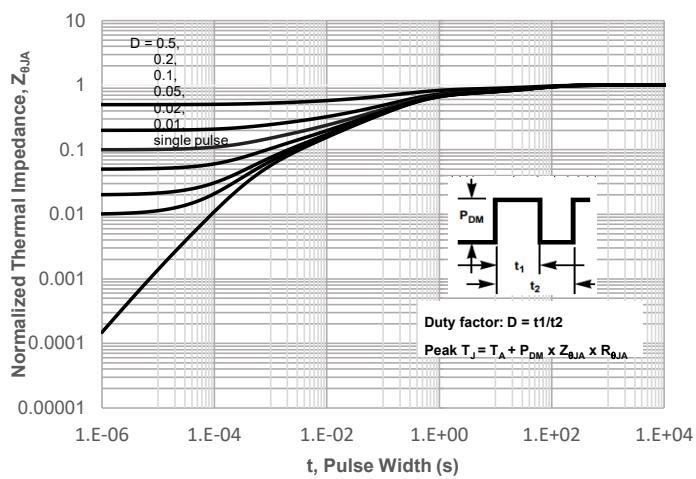
**Figure 9: Maximum Safe Operating Area**



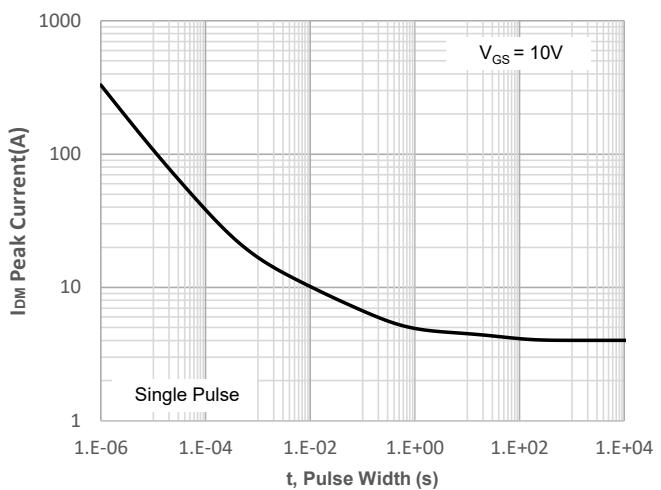
**Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature**



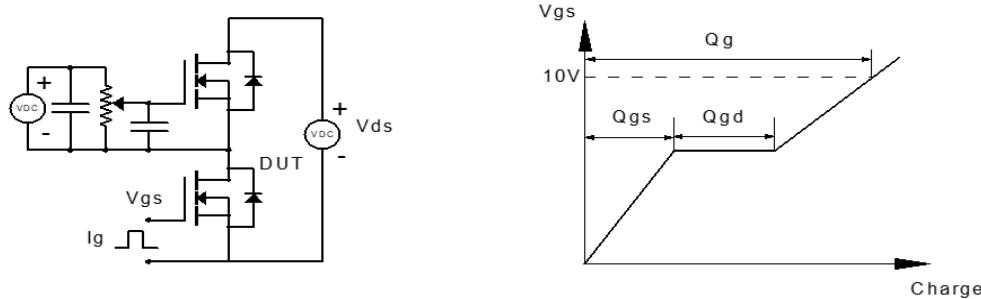
**Figure 11: Normalized Maximum Transient Thermal Impedance**



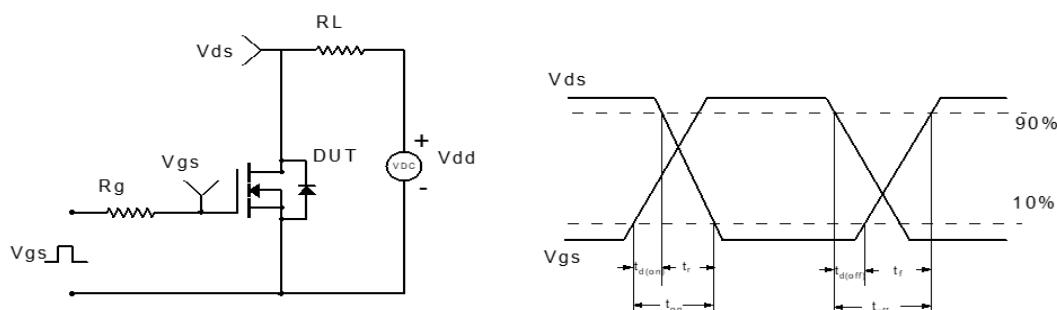
**Figure 12: Peak Current Capacity**



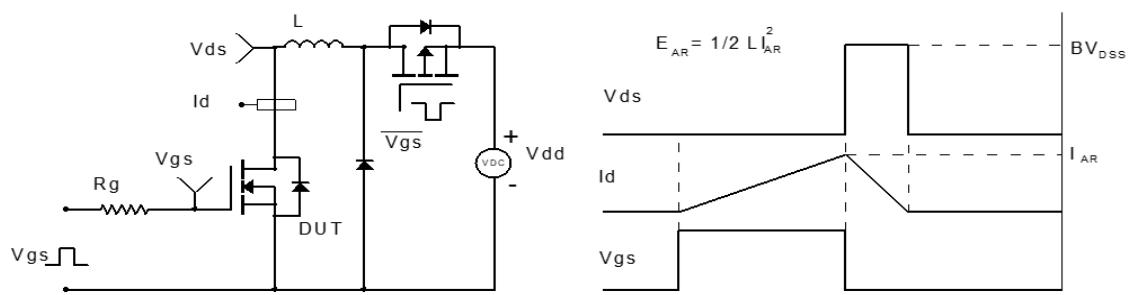
## Test Circuit



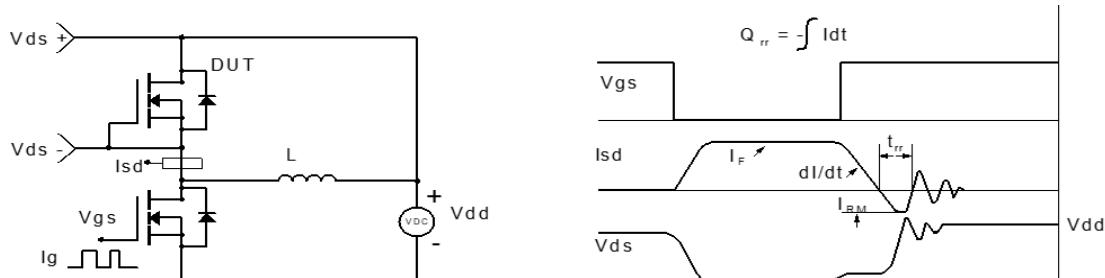
**Figure 1: Gate Charge Test Circuit & Waveform**



**Figure 2: Resistive Switching Test Circuit & Waveform**

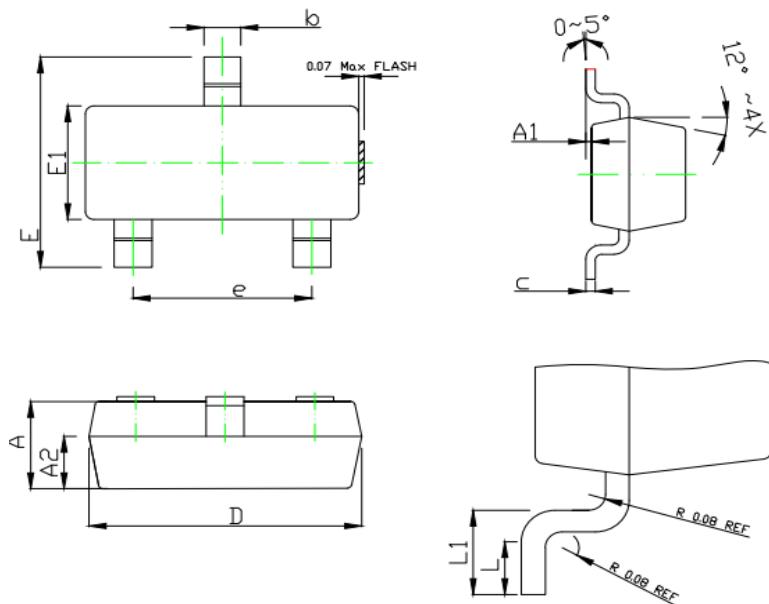


**Figure 3: Unclamped Inductive Switching Test Circuit& Waveform**



**Figure 4: Diode Recovery Test Circuit & Waveform**

## Package Mechanical Data(SOT-23)



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.95	1.00	1.05
A1	0.01	0.05	0.10
b	0.35	0.40	0.45
c	0.11 BSC		
D	2.80	2.90	3.00
E	2.30	2.40	2.50
B1	1.20	1.30	1.40
e	1.90 BSC		
L	0.20	-	-
L1	0.30	0.40	0.50
A2	0.60 REF		

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